



Certificate of Analysis

ULTRAgrade™ Solution
Vanadium ICP Standard
10000 µg/mL
(light sensitive)

Catalog Number: ICP-123
Lot Number: P00965
Job Number: J00015204
Lot Issue Date: 09/24/2012
Expiration Date: 10/31/2019

Starting Material: Ammonium Metavanadate
Starting Material Purity: 99.999%
Starting Material Lot No.: BH01951
Matrix: 10% nitric acid, 2% hydrofluoric acid in low TOC water (< 50 ppb)
Atomic Weight V: 50.95

Certified Value: 10012 ± 20 µg/mL

This Certified Reference Material (CRM) was manufactured and verified in accordance with ULTRA's ISO 9001 registered quality system. The analyte concentrations were verified by our ISO 17025 accredited laboratory to be within ± 2.5%, when compared to calibration standards independently prepared using NIST SRM(s). The certified value and uncertainty value at the 95% confidence level for each analyte is determined gravimetrically.

Classical Wet Assay Method: Theoretical, based on gravimetric measurements

Confirmation by Inductively Coupled Plasma Spectroscopy (ICP / ICP-MS) vs. NIST SRM 3165

ULTRA uses purified acids, 18 megohm double deionized water, calibrated Class A glassware & meticulously cleaned bottles in the manufacturing of ULTRAgrade standards. Balances used in the manufacturing of this standard are calibrated with weights traceable to NIST in compliance with ANSI/NCCL Z-540-1 and ISO 9001.

Trace Metallic Impurities in Solution Standard in µg/mL:

*	Al	<0.005	ND	*	Ga	<0.005	ND	n	Nb		n	S			
*	Sb	<0.005	ND	n	Ge			n	Os		n	Ta			
*	As	<0.005	ND	n	Au			*	Pd	<0.005	ND	n	Te		
*	Ba	<0.020	D	n	Hf			*	P	<0.005	ND	n	Tb		
*	Be	<0.005	ND	n	Ho			*	Pt	<0.005	ND	*	Tl	<0.005	ND
*	Bi	<0.005	ND	*	In	<0.005	ND	*	K	<0.005	ND	n	Th		
*	B	<0.005	ND	n	Ir			n	Pr			n	Tm		
*	Cd	<0.005	ND	*	Fe	<0.005	ND	n	Re			*	Sn	<0.005	ND
*	Ca	<0.005	ND	*	La	<0.005	ND	n	Rh			*	Ti	<0.005	ND
n	Ce			*	Pb	<0.005	ND	n	Rb			n	W		
n	Cs			*	Li	<0.005	ND	n	Ru			n	U		
*	Cr	<0.050	D	n	Lu			n	Sm			s	V		
*	Co	<0.005	ND	*	Mg	<0.005	ND	n	Sc			n	Yb		
*	Cu	<0.005	ND	*	Mn	<0.005	ND	*	Se	<0.005	ND	n	Y		
n	Dy			*	Hg	<0.005	ND	*	Si	<0.005	ND	*	Zn	<0.005	ND
*	Er	<0.005	ND	*	Mo	<0.005	ND	*	Ag	<0.005	ND	n	Zr		
*	Eu	<0.005	ND	n	Nd			*	Na	<0.020	D				
*	Gd	<0.005	ND	*	Ni	<0.005	ND	*	Sr	<0.005	ND				

* - element checked for
ND - not detected

i - spectral interference
D - detected

n - not checked for
s - solution standard element

Density of Solution (measured at 20.00°C ± 0.05°C): 1.0710 g/mL



ISO 9001 Registered Quality System – TUV USA


William J. Leary
Quality Assurance Manager